

□ MN101C58 Series

| Type | MN101C589 | MN101C58A | MN101CF58D | MN101CP58A |
|------------------------------------|---|-----------|------------|------------|
| Internal ROM type | Mask ROM | | FLASH | EPROM |
| ROM (byte) | 24K | 32K | 64K | 32K |
| RAM (byte) | 1.5K | | 2K | 1.5K |
| Package (Lead-free) | LQFP064-P-1414 | | | |
| Minimum Instruction Execution Time | 0.1 μs (at 4.5 V to 5.5 V, 20 MHz) 0.25 μs (at 2.7 V to 5.5 V, 8 MHz)* ¹ 62.5 μs (at 2.0 V to 5.5 V, 32 kHz)* ^{1,*2} *1: The lower limit for operation guarantee for flash memory built-in type is 4.5 V. *2: The lower limit for operation guarantee for EPROM built-in type is 2.3 V. | | | |

■ Interrupts

RESET. Watchdog. External 0 to 2. External 4 (key interrupt dedicated). Timer 0 to 3. Timer 6. Timer 7 (2 systems). Timer 8 (2 systems). Time base. Serial 0 (2 systems). A/D conversion finish

■ Timer Counter

8-bit timer × 5

Timer 0Square-wave/8-bit PWM output. Event count. Remote control carrier output. Simple pulse width measurement. Square-wave/PWM output to large current terminal P50 possible

Timer 1Square-wave output. Event count. Synchronous output event

Timer 2Square-wave output. Added pulse (2-bit) type PWM output. Event count. Synchronous output event. Simple pulse width measurement. Square-wave/PWM output to large current terminal P52 possible

Timer 3Square-wave output. Event count. Remote control carrier output. Serial 0 baud rate timer

Timer 68-bit freerun timer

Timer 0, 1 can be cascade-connected

Timer 2, 3 can be cascade-connected

16-bit timer × 2

Timer 7Square-wave output. Square-wave/16-bit PWM output (cycle/duty continuous variable). Event count. Synchronous output event. Pulse width measurement. Input capture. Square-wave/PWM output to large current terminal P51 possible

Timer 8Square-wave/16-bit PWM output (duty continuous variable). Event count. Pulse width measurement. Input capture. Square-wave/PWM output to large current terminal P53 possible

Timer 7, 8 can be cascade-connected: Square-wave output, PWM, input capture, pulse width measurement is possible as a 32-bit timer

Time base timer: One-minute count setting

Watchdog timer × 1

■ Serial interface

Synchronous type/UART (full-duplex) × 1: Serial 0

■ I/O Pins

I/O 46 : Common use. Specified pull-up resistor available. Input/output selectable (bit unit)

Input 3 : Common use. Specified pull-up resistor available

■ A/D converter

10-bit × 8 channels (with S/H)

■ Display control function

LCD: 24 segments × 4 commons (Static, 1/2, 1/3, or 1/4 duty)

LCD power supply separated from VDD (usable if $VDD \leq VLCD \leq 5.5 V$)

LCD power step-up circuit contained (3/2 times, 2 times and 3 times)

LCD power shunt resistance contained

■ Special Ports

Buzzer output. Remote control carrier output. High-current drive port

■ Electrical Characteristics (Supply current)

| Parameter | Symbol | Condition | Limit | | | Unit |
|--------------------------|--------|---|-------|-----|-----|------|
| | | | min | typ | max | |
| Operating supply current | IDD1 | fosc = 20 MHz. VDD = 5 V | | 25 | 60 | mA |
| | IDD2 | fosc = 8 MHz. VDD = 5 V | | 10 | 25 | mA |
| | IDD3 | fx = 32 kHz. VDD = 3 V | | 30 | 100 | μA |
| Supply current at HALT | IDD4 | fx = 32 kHz. VDD = 3 V. Ta = 25 °C | | 4 | 8 | μA |
| | IDD5 | fx = 32 kHz. VDD = 3 V. Ta = -40 °C to +85 °C | | | 30 | μA |
| Supply current at STOP | IDD6 | VDD = 5 V. Ta = 25 °C | | | 2 | μA |
| | IDD7 | VDD = 5 V. Ta = -40 °C to +85 °C | | | 50 | μA |

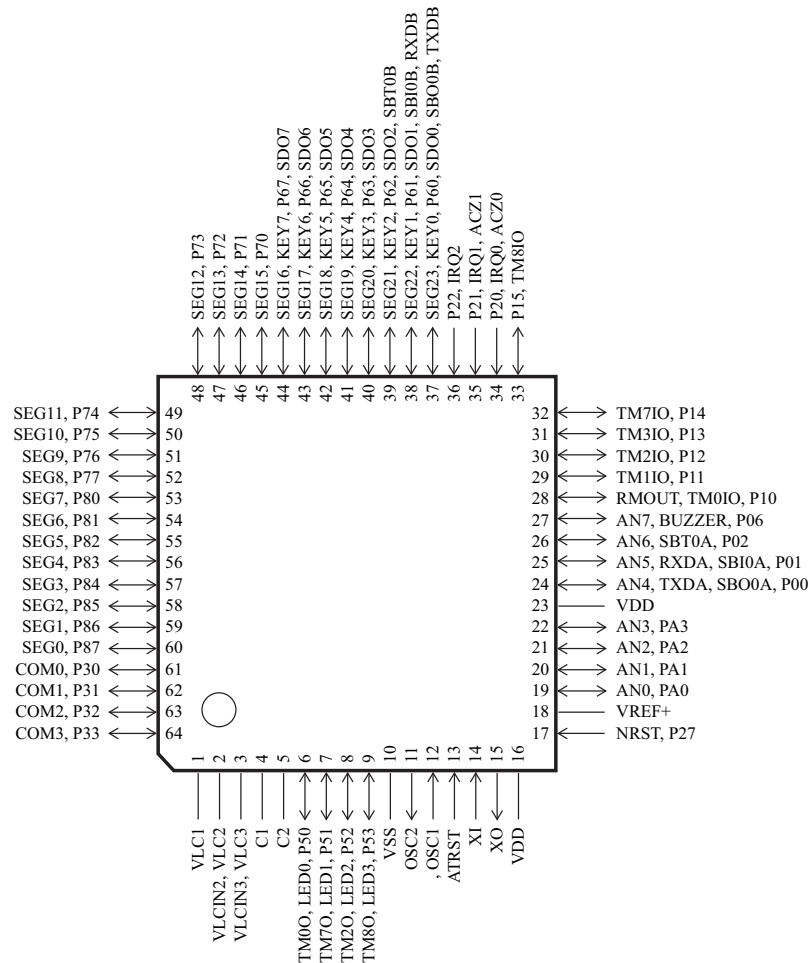
■ Development tools

In-circuit Emulator

PX-ICE101C/D + PX-PRB101C58-LQFP064-P-1414-M

■ Pin Assignment

LQFP064-P-1414



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